Issue	Classif	fication

Application/Control No.	Applicant(s)/Patent under Reexamination
10/722,543	LEE ET AL.
Examiner	Art Unit
Tan Ho	2821

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	ORIGINAL CROSS REFERENCE(S)														
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(Assistant Examiner) (Date)					<u> </u>		TAN HO	fo	Total Claims Allowed: (O						
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⊠ cı	Claims renumbered in the same order as presented by applicant							□СРА			□ T.D.			☐ R.1.47					
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